TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π–MOSV)

# 2SK2776

# Chopper Regulator, DC-DC Converter and Motor Drive Applications

 $\begin{array}{ll} \bullet & Low\ drain-source\ ON\ resistance & : R_{DS}\ (ON) = 0.75\ \Omega\ (typ.) \\ \bullet & High\ forward\ transfer\ admittance & : |Y_{fs}| = 7.0\ S\ (typ.) \\ \bullet & Low\ leakage\ current & : I_{DSS} = 100\ \mu A\ (max)\ (V_{DS} = 500\ V) \\ \bullet & Enhancement\ mode & : V_{th} = 2.0 \sim 4.0\ V\ (V_{DS} = 10\ V,\ I_{D} = 1\ mA) \\ \end{array}$ 

#### Absolute Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit
Drain-source voltage		$V_{DSS}$	500	V
Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)		$V_{DGR}$	500	V
Gate-source voltage		$V_{GSS}$	±30	V
Drain current	DC (Note 1)	I <sub>D</sub>	8	Α
	Pulse (Note 1)	I <sub>DP</sub>	32	Α
Drain power dissipatio	n (Tc = 25°C)	$P_{D}$	65	W
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	312	mJ
Avalanche current		I <sub>AR</sub>	8	Α
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	6.5	mJ
Channel temperature		T <sub>ch</sub>	150	°C
Storage temperature range		T <sub>stg</sub>	-55~150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	1.92	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	83.3	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

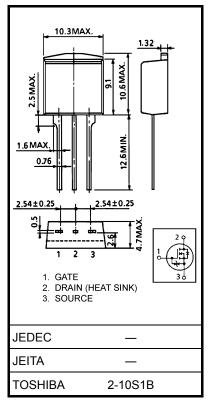
Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 8.3 mH,  $R_G$  = 25  $\Omega$ ,

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

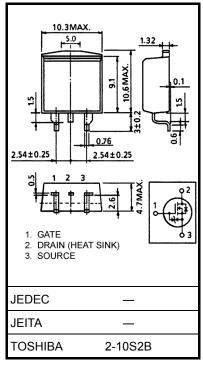
This transistor is an electrostatic-sensitive device.

Please handle with caution.

Unit: mm



Weight: 1.5 g (typ.)



Weight: 1.5 g (typ.)



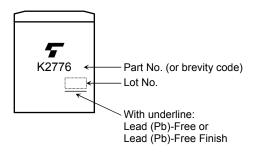
## Electrical Characteristics (Ta = 25°C)

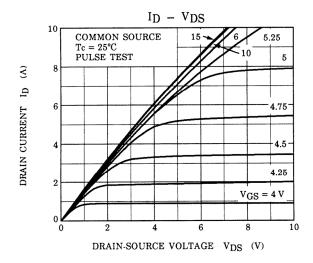
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±25 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Gate-source bre	eakdown voltage	V (BR) GSS	I <sub>G</sub> = ±10 μA, V <sub>DS</sub> = 0 V	±30	_	_	V
Drain cut-off cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		_	100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	500	_	_	V
Gate threshold v	oltage/	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R <sub>DS</sub> (ON)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4 A	-	0.75	0.85	Ω
Forward transfer	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 4 A	3.5	7.0	_	S
Input capacitano	e	C <sub>iss</sub>		-	1300	_	
Reverse transfe	r capacitance	C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		130	_	pF
Output capacita	nce	Coss			400	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS} = 10V$ $V_{GS} = 10V$ $V_{OUT}$ $V_{CS} = 100V$	_	26	_	
	Turn-on time	t <sub>on</sub>		_	45	_	ne
	Fall time	t <sub>f</sub>		_	40	_	ns -
	Turn-off time	t <sub>off</sub>	$V_{DD} = 200V$ Duty $\leq 1\%$ , $t_{W} = 10 \mu s$	_	140	_	
Total gate charg plus gate-drain)		Qg			30	_	
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 80 \text{ A}$		17	_	nC
Gate-drain ("miller") Charge		Q <sub>gd</sub>			13	_	

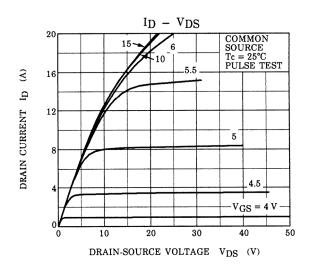
### **Source-Drain Ratings and Characteristics (Ta = 25°C)**

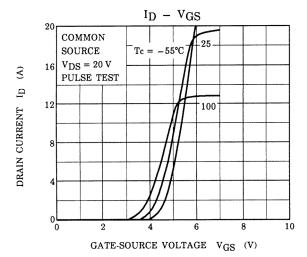
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	8	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>		_	_	32	Α
Forward voltage (diode)	$V_{DSF}$	I <sub>DR</sub> = 8 A, V <sub>GS</sub> = 0 V	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	$I_{DR}$ = 8 A, $V_{GS}$ = 0 V, $dI_{DR}$ / $dt$ = 100 A / $\mu$ s	_	1200	_	ns
Reverse recovery charge	Q <sub>rr</sub>		_	10	_	μC

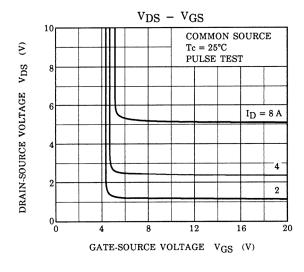
## Marking

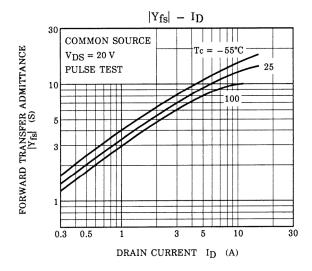


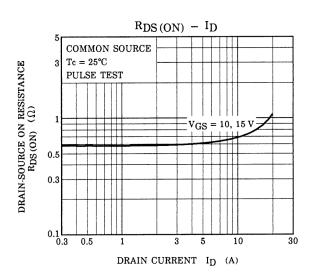


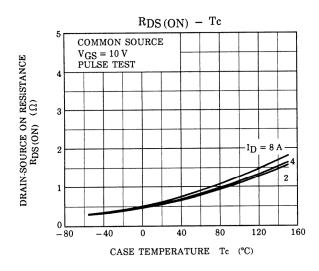


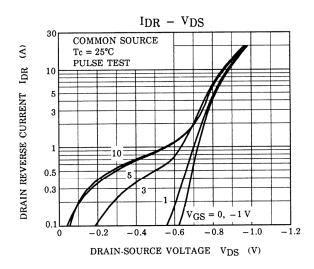


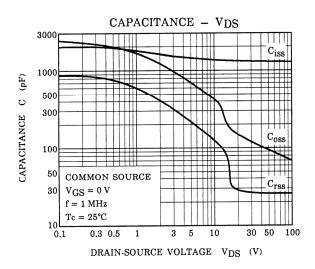


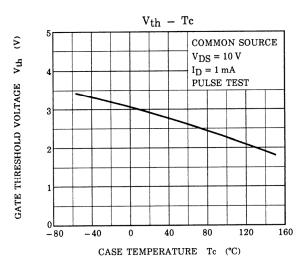


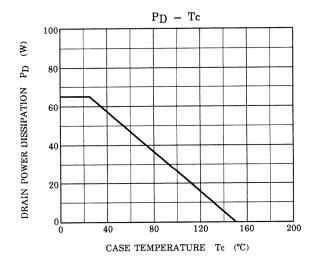


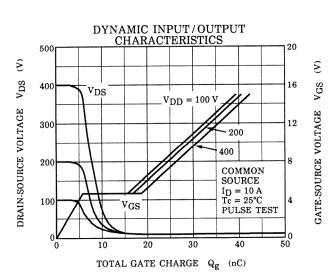


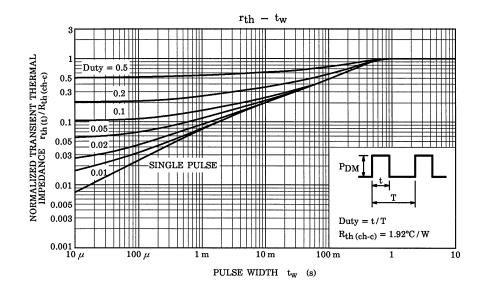


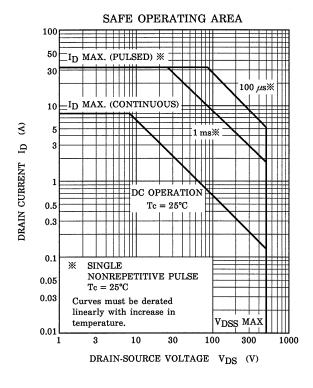


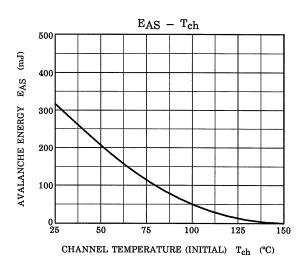


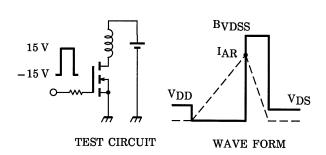












$$R_G = 25 \Omega$$
  
 $V_{DD} = 90 \text{ V, L} = 8.3 \text{ mH}$ 

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$$E_{AS} = \frac{1}{2} \cdot L \cdot I^{2} \cdot \left( \frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

#### **RESTRICTIONS ON PRODUCT USE**

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